

Notice of References Cited	Application/Control No. 10/757,844	Applicant(s)/Patent Under Reexamination BOWSER, TODD S.	
	Examiner BRIAN P. YENKE	Art Unit 2622	Page 1 of 1

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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